# **Power MOSFET** 60 V, 38 A, 16 mΩ, Single N–Channel

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant



# **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
60 V	16 m $\Omega$ @ 10 V	38 A
	19 mΩ @ 4.5 V	50 A

D

<b>MAXIMUM RATINGS</b> (T <sub>J</sub> = $25^{\circ}$ C unless otherwise noted)					
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		$T_C = 25^{\circ}C$	۱ <sub>D</sub>	38	А
rent $R_{\theta JC}$ (Notes 1 & 3)	Steady	$T_C = 100^{\circ}C$		27	
Power Dissipation $R_{\theta JC}$	State	$T_C = 25^{\circ}C$	PD	49	W
(Note 1)		$T_{C} = 100^{\circ}C$		25	
Continuous Drain Cur-	Steady State	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	10	А
rent $R_{\theta JA}$ (Notes 1, 2 & 3)		$T_A = 100^{\circ}C$		7.0	
Power Dissipation $R_{\theta JA}$		$T_A = 25^{\circ}C$	PD	3.1	W
(Notes 1 & 2)		$T_A = 100^{\circ}C$		1.5	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	203	А
Current Limited by Package (Note 3)	T <sub>A</sub>	= 25°C	I <sub>Dmaxpkg</sub>	60	A
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	38	А
Single Pulse Drain-to-Source Avalanche Energy (L = 0.1 mH)			E <sub>AS</sub>	36	mJ
			I <sub>AS</sub>	27	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

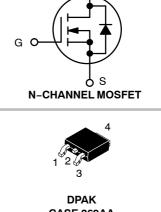
#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	3.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	49	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



CASE 369AA STYLE 2

### MARKING DIAGRAM & PIN ASSIGNMENT



Gate Source

Y = Year WW = Work Week V5865L = Device Code G = Pb-Free Package

#### **ORDERING INFORMATION**

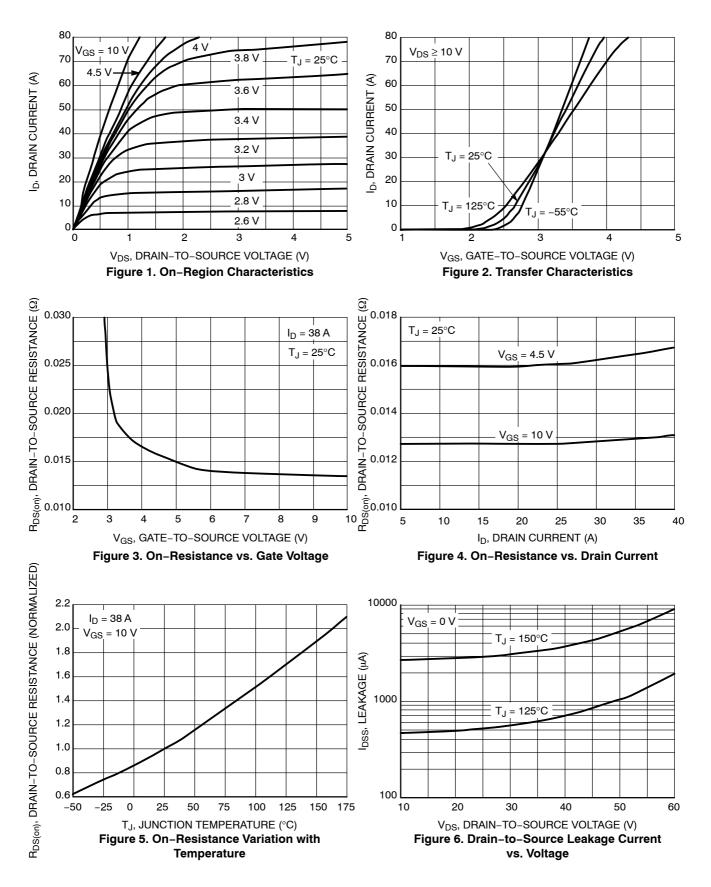
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

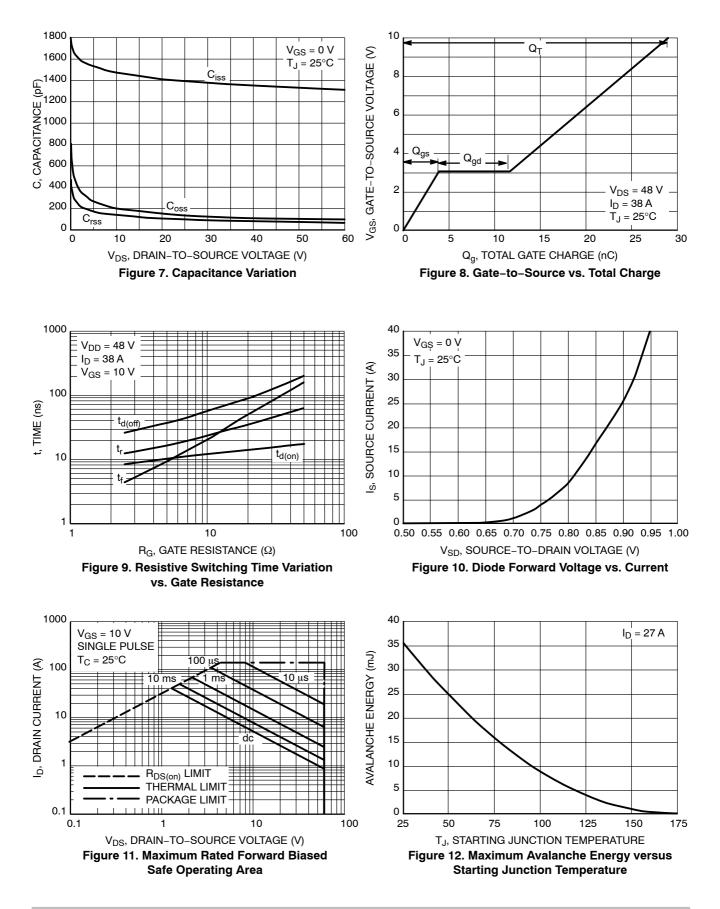
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				55		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 60 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C			1.0 100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	-			±100	nA
ON CHARACTERISTICS (Note 4)					1		1
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	= 250 μA	1.0		2.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	<u>do 10, 1</u>			5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>[</sub>	<sub>0</sub> = 19 A		13	16	mΩ
Drain-to-Source on Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I	<sub>D</sub> = 19 A		16	19	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>E</sub>	<sub>0</sub> = 19 A		15		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S					
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			1400		pF
Output Capacitance	C <sub>oss</sub>				137		
Reverse Transfer Capacitance	C <sub>rss</sub>	•DS - 20			95		
Total Gate Charge	Q <sub>G(TOT)</sub>				29		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 48 V, I_D = 38 A			1.1		
Gate-to-Source Charge	Q <sub>GS</sub>				4		
Gate-to-Drain Charge	Q <sub>GD</sub>				8		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 48 V, I <sub>D</sub> = 38 A			15		nC
Gate Resistance	R <sub>G</sub>				1.3		Ω
SWITCHING CHARACTERISTICS (No	ote 5)						
Turn-On Delay Time	t <sub>d(on)</sub>				8.4		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>D</sub> = 48 V,		12.4		
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 38 A, R <sub>G</sub>	= 2.5 Ω		26		
Fall Time	t <sub>f</sub>	1			4.4		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.95	1.2	V
		$I_{\rm S} = 38  {\rm A}$ $T_{\rm J} = 125^{\circ}{\rm C}$			0.85		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 38 A			20		ns
Charge Time	ta				13		1
Discharge Time	tb				7		1
Reverse Recovery Charge	Q <sub>RR</sub>				13		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



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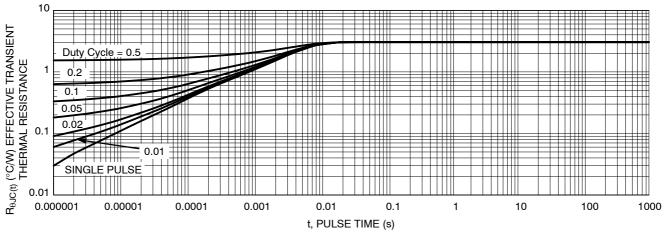


Figure 13. Thermal Response

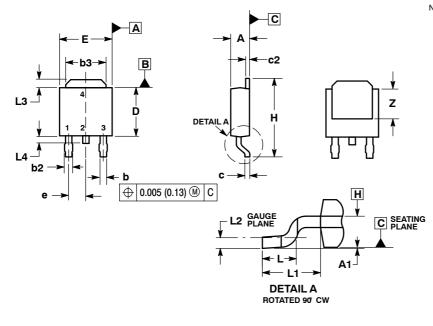
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NVD5865NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

DPAK CASE 369AA-01 ISSUE B

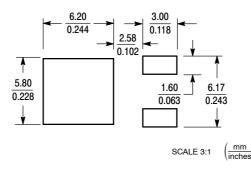


NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z. 3.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29	BSC
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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